•	Application No.	Applicant(s)
A	09/840,359	KANDOU ET AL.
Notice of Allowability	Examiner	Art Unit
	Karen B Addison	2834
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.		
1. \square This communication is responsive to $2/22/05$.		
2. ☑ The allowed claim(s) is/are <u>3-14</u> .		
3. The drawings filed on <u>15 June 2004</u> are accepted by the Examiner.		
4.		
attached Examiner's comment regarding REQUIREMENT Attachment(s)	,	
1. Notice of References Cited (PTO-892)	<u> </u>	Patent Application (PTO-152)
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6. ☐ Interview Summary Paper No./Mail Dat	(PTO-413), te .
 Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date <u>2/22/05,1/30/04</u> 	08), 7. Examiner's Amendr	nent/Comment
4. ☐ Examiner's Comment Regarding Requirement for Deposit		ent of Reasons for Allowance
of Biological Material	9. 🔲 Other	

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DETAILED ACTION

Response to Arguments

1. Applicant's arguments, see pages 8-12 filed 2/5/04, with respect to claims 3-14 have been fully considered and are persuasive. The non-final of rejection has been withdrawn.

Allowable Subject Matter

Claims 3-14 are allowed.

The following is an examiner's statement of reasons for allowance: Prior art fails to show: a quartz substrate; a piezoelectric thin film (zno) disposed on the quartz substrate; comb electrodes disposed between the quartz substrate and the piezoelectric thin film. Wherein, the normalized film thickness H/ λ , of the piezoelectric thin film is at least about 0.20, wherein the film thickness of the piezoelectric thin film is H, and the wavelength of the surface acoutic wave is λ , Wherein, the Euler angles of the quartz substrate are within the range such that the temperature coefficient of frequency TCF(having a negative value) of the surface acoustic wave device is within about : ± 25 ppm/°c, ± 5 ppm/°c and the electromechanicl coefficient of the Rayleigh wave is no smaller than about 0.8% and not larger than $\pm 1^\circ$.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

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Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Karen B Addison whose telephone number is 571-272-2017. The examiner can normally be reached on 8:00 to 4:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nestor Ramirez can be reached on 703-308-1317. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

KBA 3/5/05

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